


<b>Search Notes</b>  	<b>Application/Control No.</b>  10582198	<b>Applicant(s)/Patent Under Reexamination</b>  SHEN, YANG
	<b>Examiner</b>  Gluchowski, Kristina R	<b>Art Unit</b>  3676

SEARCHED			
Class	Subclass	Date	Examiner
70	495, 382, 384	5/9/07	KRG
	updated	12/10/07	KRG
70	495	12/21/08	KRF
	used search from 10/888454	12/21/08	KRF

SEARCH NOTES		
Search Notes	Date	Examiner
text "rekeyable" "re-keyable"	5/9/07	KRG
text "second key"	12/10/07	KRG

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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Examiner.Art Unit 3673